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|---------------------------|---|
| <u>#1</u> | ((generat <near> offload <near> data and protocol <near> stack and switch)<IN>metadata) |
| <u>#2</u> | ((generat <near> offload <near> data and protocol) <IN>metadata) |
| <u>#3</u> | ((generat <near> offload <near> data <near> structure) <IN>metadata) |
| <u>#4</u> | ((detect* <near> fail-over or failover and peripheral <near> device*)<IN>metadata) |
| <u>#5</u> | ((detect* <near> fail* <near> link* and offload)<IN>metadata) |
| <u>#6</u> | ((detect* <near> fail* <near> link*)<IN>metadata) |
| <u>#7</u> | ((shar* <near> common <near> path)<IN>metadata) |



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